

# TC7SZ04AFS

## 1. Functional Description

- Inverter

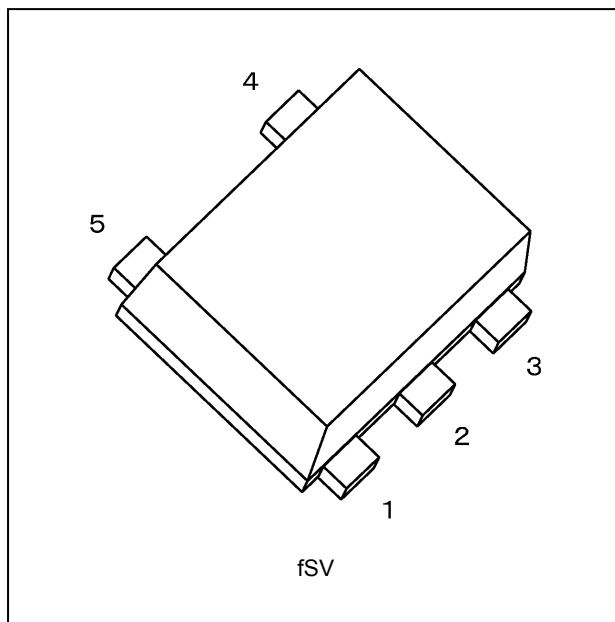
## 2. Features

- (1) AEC-Q100 (Rev. H) (Note 1)
- (2) Wide operating temperature range:  $T_{opr} = -40$  to  $125^{\circ}\text{C}$  (Note 2)
- (3) High output current:  $\pm 24$  mA (min) at  $V_{CC} = 3.0$  V
- (4) Super high speed operation:  $t_{pd} = 2.4$  ns (typ.) at  $V_{CC} = 5.0$  V,  $C_L = 50$  pF
- (5) Operation voltage range:  $V_{CC} = 1.65$  to  $5.5$  V
- (6)  $5.5$  V tolerant inputs

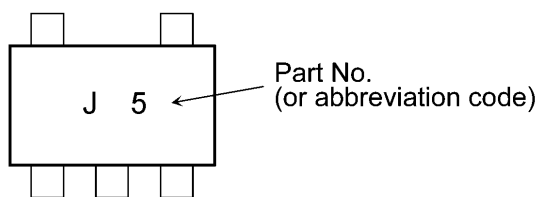
Note 1: This device is compliant with the reliability requirements of AEC-Q100. For details, contact your Toshiba sales representative.

Note 2: For devices with the ordering part number ending in J(T.  $T_{opr} = -40$  to  $85^{\circ}\text{C}$  for the other devices.

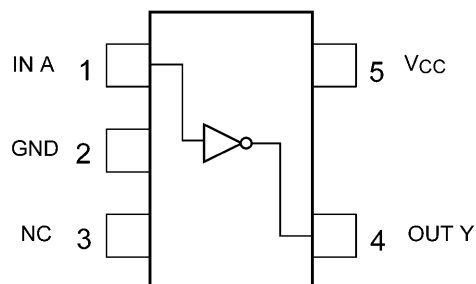
## 3. Packaging



## 4. Marking and Pin Assignment



Marking



Pin Assignment (Top view)

Start of commercial production

2008-03

## 5. IEC Logic Symbol



## 6. Truth Table

A	Y
L	H
H	L

## 7. Absolute Maximum Ratings (Note) (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	$V_{CC}$		-0.5 to 6.0	V
Input voltage	$V_{IN}$		-0.5 to 6.0	V
DC output voltage	$V_{OUT}$		-0.5 to $V_{CC} + 0.5$	V
Input diode current	$I_{IK}$		-20	mA
Output diode current	$I_{OK}$	(Note 1)	$\pm 20$	mA
DC output current	$I_{OUT}$		$\pm 50$	mA
$V_{CC}$ /ground current	$I_{CC}$		$\pm 50$	mA
Power dissipation	$P_D$		50	mW
Storage temperature	$T_{stg}$		-65 to 150	$^{\circ}\text{C}$

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 1:  $V_{OUT} < \text{GND}$ ,  $V_{OUT} > V_{CC}$

## 8. Operating Ranges (Note)

Characteristics	Symbol	Note	Test Condition	Rating	Unit
Supply voltage	$V_{CC}$		—	1.65 to 5.5	V
		(Note 1)	—	1.5 to 5.5	
Input voltage	$V_{IN}$		—	0 to 5.5	V
Output voltage	$V_{OUT}$		—	0 to $V_{CC}$	V
Operating temperature	$T_{opr}$	(Note 2)	—	-40 to 125	$^{\circ}\text{C}$
		(Note 3)	—	-40 to 85	
Input rise and fall time	$dt/dv$		$V_{CC} = 1.8 \pm 0.15\text{ V}, 2.5 \pm 0.2\text{ V}$	0 to 20	ns/V
			$V_{CC} = 3.3 \pm 0.3\text{ V}$	0 to 10	
			$V_{CC} = 5.0 \pm 0.5\text{ V}$	0 to 5	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either  $V_{CC}$  or GND.

Note 1: Data retention only

Note 2: For devices with the ordering part number ending in J(T).

Note 3: For devices except those with the ordering part number ending in J(T).

## 9. Electrical Characteristics

### 9.1. DC Characteristics (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Typ.	Max	Unit
High-level input voltage	$V_{IH}$	—		1.65 to 1.95	$V_{CC} \times 0.75$	—	—	V
				2.3 to 5.5	$V_{CC} \times 0.7$	—	—	
Low-level input voltage	$V_{IL}$	—		1.65 to 1.95	—	—	$V_{CC} \times 0.25$	V
				2.3 to 5.5	—	—	$V_{CC} \times 0.3$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IL}$	$I_{OH} = -100\text{ }\mu\text{A}$	1.65	1.55	1.65	—	V
				2.3	2.2	2.3	—	
				3.0	2.9	3.0	—	
				4.5	4.4	4.5	—	
			$I_{OH} = -4\text{ mA}$	1.65	1.29	1.52	—	
			$I_{OH} = -8\text{ mA}$	2.3	1.9	2.15	—	
			$I_{OH} = -16\text{ mA}$	3.0	2.4	2.8	—	
			$I_{OH} = -24\text{ mA}$	3.0	2.3	2.68	—	
			$I_{OH} = -32\text{ mA}$	4.5	3.8	4.2	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IH}$	$I_{OL} = 100\text{ }\mu\text{A}$	1.65	—	0.0	0.1	V
				2.3	—	0.0	0.1	
				3.0	—	0.0	0.1	
				4.5	—	0.0	0.1	
			$I_{OL} = 4\text{ mA}$	1.65	—	0.08	0.24	
			$I_{OL} = 8\text{ mA}$	2.3	—	0.1	0.3	
			$I_{OL} = 16\text{ mA}$	3.0	—	0.15	0.4	
			$I_{OL} = 24\text{ mA}$	3.0	—	0.22	0.55	
			$I_{OL} = 32\text{ mA}$	4.5	—	0.22	0.55	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V or GND}$		0 to 5.5	—	—	$\pm 1$	$\mu\text{A}$
Quiescent supply current	$I_{CC}$	$V_{IN} = V_{CC}\text{ or GND}$		5.5	—	—	2	$\mu\text{A}$

9.2. DC Characteristics (Unless otherwise specified,  $T_a = -40$  to  $85\text{ }^\circ\text{C}$ )

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Max	Unit
High-level input voltage	$V_{IH}$	—		1.65 to 1.95	$V_{CC} \times 0.75$	—	V
				2.3 to 5.5	$V_{CC} \times 0.7$	—	
Low-level input voltage	$V_{IL}$	—		1.65 to 1.95	—	$V_{CC} \times 0.25$	V
				2.3 to 5.5	—	$V_{CC} \times 0.3$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IL}$	$I_{OH} = -100\text{ }\mu\text{A}$	1.65	1.55	—	V
				2.3	2.2	—	
				3.0	2.9	—	
				4.5	4.4	—	
			$I_{OH} = -4\text{ mA}$	1.65	1.29	—	
			$I_{OH} = -8\text{ mA}$	2.3	1.9	—	
			$I_{OH} = -16\text{ mA}$	3.0	2.4	—	
			$I_{OH} = -24\text{ mA}$	3.0	2.3	—	
			$I_{OH} = -32\text{ mA}$	4.5	3.8	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IH}$	$I_{OL} = 100\text{ }\mu\text{A}$	1.65	—	0.1	V
				2.3	—	0.1	
				3.0	—	0.1	
				4.5	—	0.1	
			$I_{OL} = 4\text{ mA}$	1.65	—	0.24	
			$I_{OL} = 8\text{ mA}$	2.3	—	0.3	
			$I_{OL} = 16\text{ mA}$	3.0	—	0.4	
			$I_{OL} = 24\text{ mA}$	3.0	—	0.55	
			$I_{OL} = 32\text{ mA}$	4.5	—	0.55	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V or GND}$		0 to 5.5	—	$\pm 10$	$\mu\text{A}$
Quiescent supply current	$I_{CC}$	$V_{IN} = V_{CC}\text{ or GND}$		5.5	—	20	$\mu\text{A}$

9.3. DC Characteristics (Note) (Unless otherwise specified,  $T_a = -40$  to  $125\text{ }^{\circ}\text{C}$ )

Characteristics	Symbol	Test Condition		$V_{CC}$ (V)	Min	Max	Unit
High-level input voltage	$V_{IH}$	—		1.65 to 1.95	$V_{CC} \times 0.75$	—	V
				2.3 to 5.5	$V_{CC} \times 0.7$	—	
Low-level input voltage	$V_{IL}$	—		1.65 to 1.95	—	$V_{CC} \times 0.25$	V
				2.3 to 5.5	—	$V_{CC} \times 0.3$	
High-level output voltage	$V_{OH}$	$V_{IN} = V_{IL}$	$I_{OH} = -100\text{ }\mu\text{A}$	1.65	1.55	—	V
				2.3	2.2	—	
				3.0	2.9	—	
				4.5	4.4	—	
			$I_{OH} = -4\text{ mA}$	1.65	0.95	—	
			$I_{OH} = -8\text{ mA}$	2.3	1.7	—	
			$I_{OH} = -16\text{ mA}$	3.0	2.2	—	
			$I_{OH} = -24\text{ mA}$	3.0	2.0	—	
			$I_{OH} = -32\text{ mA}$	4.5	3.4	—	
Low-level output voltage	$V_{OL}$	$V_{IN} = V_{IH}$	$I_{OL} = 100\text{ }\mu\text{A}$	1.65	—	0.1	V
				2.3	—	0.1	
				3.0	—	0.1	
				4.5	—	0.1	
			$I_{OL} = 4\text{ mA}$	1.65	—	0.7	
			$I_{OL} = 8\text{ mA}$	2.3	—	0.45	
			$I_{OL} = 16\text{ mA}$	3.0	—	0.6	
			$I_{OL} = 24\text{ mA}$	3.0	—	0.8	
			$I_{OL} = 32\text{ mA}$	4.5	—	0.8	
Input leakage current	$I_{IN}$	$V_{IN} = 5.5\text{ V or GND}$		0 to 5.5	—	$\pm 20$	$\mu\text{A}$
Quiescent supply current	$I_{CC}$	$V_{IN} = V_{CC}\text{ or GND}$		5.5	—	200	$\mu\text{A}$

Note: For devices with the ordering part number ending in J(T).

#### 9.4. AC Characteristics (Unless otherwise specified, $T_a = 25\text{ }^\circ\text{C}$ , Input: $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Note	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Typ.	Max	Unit
Propagation delay time	$t_{PLH}, t_{PHL}$		$R_L = 1\text{ M}\Omega$	$1.8 \pm 0.15$	15	1.1	5.3	9.6	ns
				$2.5 \pm 0.2$		1.0	3.2	5.3	
				$3.3 \pm 0.3$		0.8	2.4	3.7	
				$5.0 \pm 0.5$		0.5	1.9	2.9	
			$R_L = 500\text{ }\Omega$	$3.3 \pm 0.3$	50	1.0	3.0	4.6	ns
				$5.0 \pm 0.5$		0.8	2.4	3.6	
Input capacitance	$C_{IN}$		—	0 to 5.5	—	—	4	—	pF
Power dissipation capacitance	$C_{PD}$	(Note 1)	—	3.3	—	—	10	—	pF
				5.5		—	15	—	pF

Note 1:  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

#### 9.5. AC Characteristics (Unless otherwise specified, $T_a = -40\text{ to }85\text{ }^\circ\text{C}$ , Input: $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Max	Unit
Propagation delay time	$t_{PLH}, t_{PHL}$	$R_L = 1\text{ M}\Omega$	$1.8 \pm 0.15$	15	1.1	9.8	ns
			$2.5 \pm 0.2$		1.0	5.7	
			$3.3 \pm 0.3$		0.8	4.0	
			$5.0 \pm 0.5$		0.5	3.2	
		$R_L = 500\text{ }\Omega$	$3.3 \pm 0.3$	50	1.0	4.9	ns
			$5.0 \pm 0.5$		0.8	3.9	

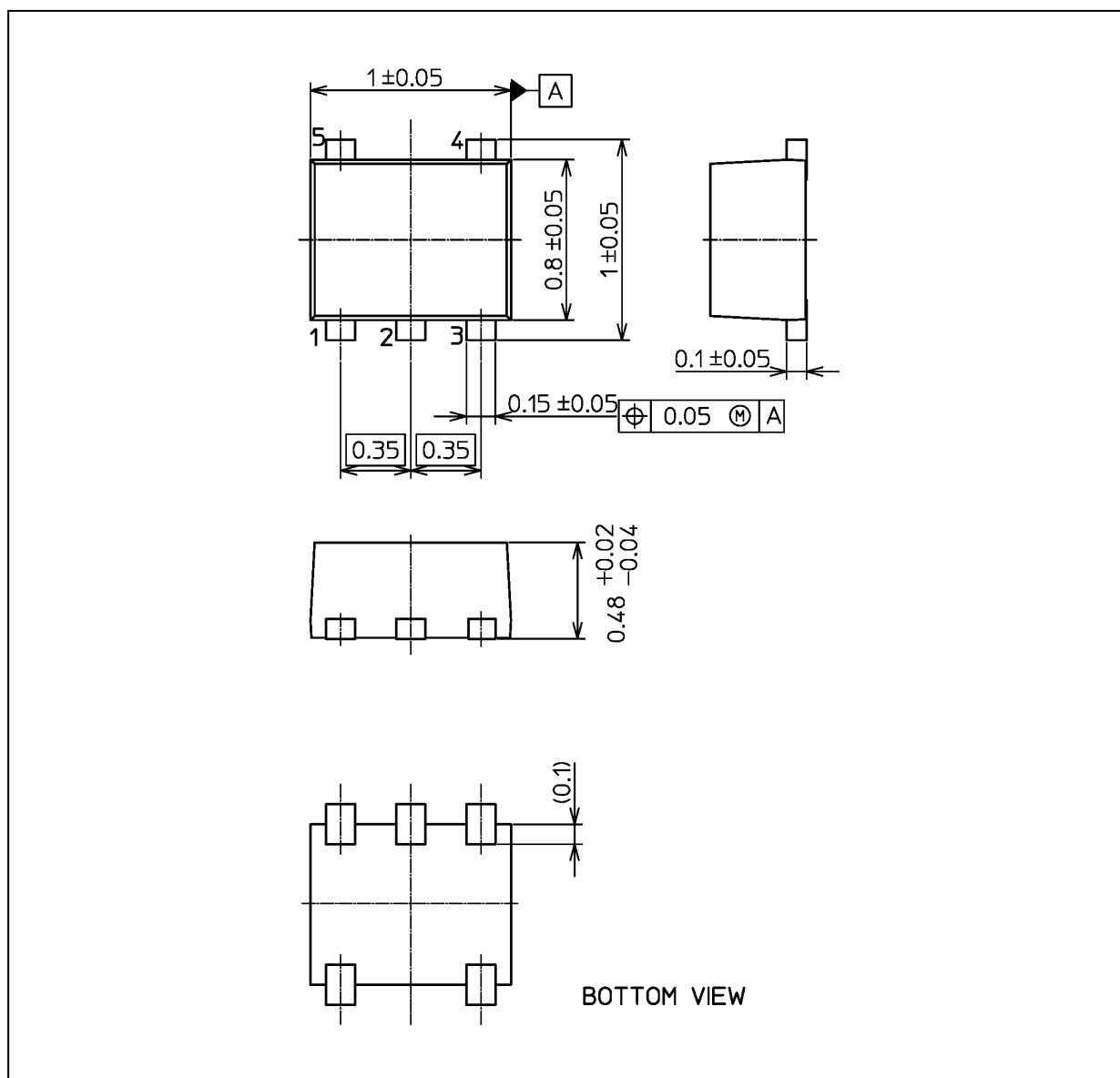
#### 9.6. AC Characteristics (Note) (Unless otherwise specified, $T_a = -40\text{ to }125\text{ }^\circ\text{C}$ , Input: $t_r = t_f = 3\text{ ns}$ )

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	$C_L$ (pF)	Min	Max	Unit
Propagation delay time	$t_{PLH}, t_{PHL}$	$R_L = 1\text{ M}\Omega$	$1.8 \pm 0.15$	15	1.1	11.0	ns
			$2.5 \pm 0.2$		1.0	6.5	
			$3.3 \pm 0.3$		0.8	4.5	
			$5.0 \pm 0.5$		0.5	4.0	
		$R_L = 500\text{ }\Omega$	$3.3 \pm 0.3$	50	1.0	5.5	ns
			$5.0 \pm 0.5$		0.8	4.5	

Note: For devices with the ordering part number ending in J(T).

## Package Dimensions

Unit: mm



Weight: 1.0 mg (typ.)

Package Name(s)
JEDEC: SOT-953
Nickname: fSV

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